

**Notice of References Cited**

Application/Control No.

09/856,236

Applicant(s)/Patent Under  
Reexamination  
KLEIN ET AL.

Examiner

Katarzyna W. Lee

Art Unit

1714

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,171,388 B1	01-2001	Jobbins	106/778
	C	US-			
	D	US-			
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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